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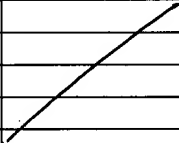
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				Application Number	09/352,362
				Filing Date	July 13, 1999
				First Named Inventor	Shunpei YAMAZAKI et al.
				Group Art Unit	2815
				Examiner Name	J. Diaz
Sheet	1	of	1	Attorney Docket Number	0756-1996

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
		6,071,796	A	Voutsas	06/06/2000	
		5,648,276	A	Hara et al.	07/15/1997	
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Examiner Initials [*]	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

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Atty Docket 0756-1996

Serial No. 09/352,362

INFORMATION DISCLOSURE STATEMENT

Applicants: Shunpei YAMAZAKI et al.

Filing Date: July 13, 1999

Group Art Unit: 2815

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
P	08-078329	03/22/1996	JP			Eng Abst

OTHER DOCUMENT (Including Author, Title, Date, Pertinent Pages, Etc.)

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W	Abe et al., "High Performance Poly-Crystalline Silicon TFT's Fabricated Using the SPC and ELA Methods", pp. 85-88, 1998, AM-LCD 98, Digest of Technical Papers
W	Specification & Drawings of US Patent Application Serial No. 09/352,373
W	Specification & Drawings of US Patent Application Serial No. 09/352,194
P	Specification & Drawings of US Patent Application Serial No. 09/352,198
P	Specification & Drawings of US Patent Application Serial No. 09/894,125
P	Specification & Drawings of US Patent Application Serial No. 09/369,158
W	Specification & Drawings of US Patent Application Serial No. 09/908,727
P	Dorin et al., "Chemistry The Study of Matter", pp. 532, 1992, Prentice Hall

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